

Search Notes

Application/Control No.

10/655,972

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

PAN ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	700	9/9/2005	BT
438	710	9/9/2005	BT
438	712	9/9/2005	BT
438	715	9/9/2005	BT

INTERFERENCE SEARCHED

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438	700	9/9/2005	BT
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438	712	9/9/2005	BT
438/715		9/9/2005	BT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update search using USPAT, USPG-PUB, EPO, JPO, DERWENT databases	9/9/2005	BT